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Si4532DY

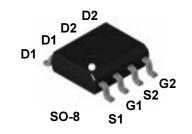
Dual N- and P-Channel Enhancement Mode Field Effect Transistor

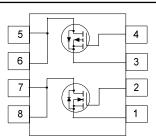
General Description

These dual N- and P-Channel enhancement mode power field effect transistors are produced using ON Semiconductor's propretary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance and provide superior switching performance. These devices are particularly suited for low voltage applications such as notebook computer power management and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- N-Channel 3.9A, 30V.R_{DS(ON)} = $0.065\Omega @V_{GS} = 10V$ R_{DS(ON)} = $0.095\Omega @V_{GS} = 4.5V.$
- P-Channel -3.5A,-30V.R_{DS(ON)} = $0.085\Omega @V_{GS} = -10V$ R_{DS(ON)} = $0.190 \Omega @V_{GS} = -4.5V.$
- High density cell design for extremely low $\mathrm{R}_{\mathrm{DS(ON)}}.$
- High power and current handling capability in a widely used surface mount package.
- Dual (N & P-Channel) MOSFET in surface mount package.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		N-Channel	P-Channel	Unit
V _{DSS}	Drain-Source Voltage		30 -30		V
/ _{GSS}	Gate-Source Voltage		20	-20	V
D	Drain Current - Continuous	(Note 1a)	3.9	-3.5	A
	- Pulsed		20	-20	
D	Power Dissipation for Dual Operation 2		2	W	
	Power Dissipation for Single Operation	(Note 1a)	1.6		
		(Note 1b)		1	
		(Note 1c)	0	.9	
J, T _{stg}	Operating and Storage Junction Temperati	ure Range	-55 to	+150	۰C
	Characteristics	ire Range	-55 to	+150	ļ
R _{eJA}	Thermal Resistance, Junction-to-Ambient		62	.5	°C/V
≺ ^{eic}	Thermal Resistance, Junction-to-Case	(Note 1)	4	0	∘C/V

Device Marking	Device	Reel Size	Tape Width	Quantity	
4532	Si4532DY	13"	12mm	2500 units	

* Die and manufacturing source subject to change without prior notification.

Si4532DY

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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown	V _{GS} = 0 V, I _D = 250 _{LL} A	N-Ch	30			V
	Voltage	$V_{GS} = 0 V_{1} I_{D} = -250 \mu A$	P-Ch	-30			V
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$	N-Ch			1	uА
		V _{DS} = -24 V, V _{GS} = 0 V	P-Ch			-1	µA
GSSF	Gate-Body Leakage, Forward	$V_{GS} = 20 V, V_{DS} = 0 V$	All			100	'nA
IGSSR	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	All			-100	nA
			NCh	4		2	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	N-Ch	1		3	<u>V</u>
	Static Drain-Source On	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	P-Ch N-Ch	-1	0.053	-3 0.065	<u>V</u>
R _{DS(on)}	Resistance	$V_{GS} = 10 V, I_D = 3.9 A$	N-Cn				Ω
		V _{GS} = 4.5 V, I _D = 3.1 A			0.081	0.095	
		$V_{GS} = -10 V_{, I_{D}} = -2.5 A$	P-Ch		0.06	0.085	
		V _{GS} = -4.5 V, I _D = -1.8 A			0.095	0.19	
D _(on)	On-State Drain Current	$V_{GS} = 10 V, V_{DS} = 5 V$	N-Ch	15			А
		$V_{GS} = -10 V_{,} V_{DS} = -5 V_{,}$	P-Ch	-15			
g fs	Forward Transconductance	$V_{DS} = 15 V_{, I_{D}} = 3.9 A$	N-Ch		7		S
		$V_{DS} = -15 V$, $I_{D} = -2.5 A$	P-Ch		5		
Dynami	c Characteristics						
Ciss	Input Capacitance	$V_{DS} = 10 V_{,} V_{GS} = 0 V_{,}$	N-Ch		235		pF
		f = 1.0 MHz	P-Ch		420		
C _{oss}	Input Capacitance	V - 10V/V - 0V	N-Ch		150		pF
		V _{DS} = -10 V, V _{GS} = 0 V, f = 1 0 MHz	P-Ch		140		
C _{rss}	Reverse Transfer Capacitance		N-Ch		49		рF
			P-Ch		60		

Si4532DY

Electrical Characteristics (continued)

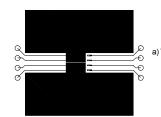
haracteristics (Note 2) n-On Delay Time n-On Rise Time	V_{DD} = 10 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	N-Ch P-Ch		7	13	
				7	13	20
n-On Rise Time				9	18	ns
		N-Ch P-Ch		18 8	29 16	ns
	V _{DD} = -10 V, I _D = -2.5 A,	P-Ch N-Ch P-Ch		0 15 18	27 29	ns
n-Off Fa∥ Time	V_{GS} = -10 V, R_{GEN} = 6 Ω	N-Ch		0.8	8	ns
		P-Ch N-Ch		6	12 80	nS
	V _{DS} = 10 V, I _D = 3.9 A,	N-Ch		3.7	15	nC
e-Source Charge		N-Ch		0.9	15	nC
	V _{GS} = -10 V	N-Ch		1.9		nC
al e	Gate Charge	-Source Charge $V_{GS} = 10 V$ $V_{DS} = -10 V$, $I_D = -2.5 A$, $V_{GS} = -10 V$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$

Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current		N-Ch		1.7	А
			P-Ch		-1.7	А
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.7 A (Note 2)	N-Ch	0.75	1.2	V
		V _{GS} = 0 V, I _S = -1.7 A (Note 2)	P-Ch	-0.75	-1.2	V

Notes:

1. R_{8,JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\rm R_{\theta JC}$ is guaranteed by design while $\rm R_{\theta CA}$ is determined by the user's board design.



a) 78° C/W when mounted on a 0.05 in² pad of 2 oz. copper.





c) 135° C/W when mounted on a minimum mounting pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

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